Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/777,142	IDE ET AL.	
Examiner	**Art Unit**	
Leith A. Al-Nazer	2821	

SEARCHED			
Class	Subclass	Date	Examiner
349	149-152	12/9/2005	LA

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated EAST prior art text search (see "Examiner Search Notes")	12/9/2005	LA